Cycle-based simulation with decision diagrams

Ubar, Raimund-Johannes; Morawiec, Adam; **Raik, Jaan** Design, Automation and Test in Europe : DATE : Conference and Exhibition 1999 : Munich, Germany, March 9-12, 1999 : proceedings 1999 / p. 454-458: ill

Sequential circuit test generation using decision diagram models

Raik, Jaan; **Ubar, Raimund-Johannes** Design, Automation and Test in Europe : DATE : Conference and Exhibition 1999 : Munich, Germany, March 9-12, 1999 : proceedings 1999 / p. 736-740: ill